Search Notes



Application/Co	ntrol No.	Applicant(s)/Patent Under Reexamination	
10693736		YUAN ET AL.	
Examiner		Art Unit	
CHAU NGUYEN	١	2176	

SEARCHED					
Class	Subclass	Date	Examiner		
715	200	04/23/2008	cn		
	204	04/23/2008	cn		
	212	04/23/2008	cn		
	215	04/23/2008	cn		
	227	04/23/2008	cn		
	234	04/23/2008	cn		
	238-239	04/23/2008	cn		
	242	04/23/2008	cn		
	254-255	04/23/2008	cn		

SEARCH NOTES				
Search Notes	Date	Examiner		
Updated Search on East Repports	03/26/2008	cn		
	03/27/2008	cn		
	04/21/2008	cn		
	04/23/2008	cn		
Inventor Search for Double Patenting	04/21/2008	cn		
NPL Search on IEEE Database	04/23/2008	cn		
Interference search on PGPUB	04/23/2008	cn		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
715	200	04/23/2008	cn		
	204	04/23/2008	cn		
	212	04/23/2008	cn		
	215	04/23/2008	cn		
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